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<th>Evaluation of Heterogeneity in Thickness of Passive Films on Pure Iron by Scanning Electrochemical Microscopy</th>
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Scanning electrochemical microscopy (SECM) was applied to evaluate the heterogeneity of a passive film formed on a pure iron electrode in deaerated pH 8.4 borate solution. A probe current image of SECM was measured with a tip-generation/substrate-collection (TG/SC) mode in deaerated pH 8.4 borate solution containing 0.03 mol dm$^{-3}$ Fe(CN)$_6^{4-}$ as a mediator. The difference in thickness of passive films formed on two iron plates at different potentials could be evaluated from the probe current image. The probe current image of the passivated iron surface with distinctive crystal grains was composed of the patch patterns, the shapes of which coincided completely with the shapes of the substrate crystal grains. The probe current flowed above the grain surface oriented to $\{100\}$ plane was less than that above the grain surface oriented to $\{110\}$ or $\{111\}$ plane. The grain orientation dependence of probe current was ascribed to the difference in thickness of passive films formed on the crystal grains.

KEY WORDS: scanning electrochemical microscopy; heterogeneity; passive film; film thickness; iron; grain orientation.

1. Introduction

Passive films formed on metals and alloys sustain corrosion resistivities of substrates. A local breakdown of passive film eventually leads to localized corrosion such as pitting. Measurements of electrochemical activities at the local sites of the passive film are important for better understanding of precursor processes of localized corrosion. Scanning electrochemical microscopy (SECM) is a useful and powerful technique for an in-situ evaluation of electrochemical reactivities at the local sites. SECM has been applied so far to many fields including microelectrochemistry, bioelectrochemistry, microfabrication and so on.

Bard et al. used SECM to examine surface oxide films on chromium and on titanium and showed that these oxide films have insulative properties. Smyrl et al. investigated the precursor processes of pitting corrosion of titanium by SECM. Wipf et al. employed SECM to investigate the breakdown of passive films on stainless steel and iron. Although these studies by SECM provided the first step for investigating the precursor processes of pitting, the heterogeneity of thickness or defective structure of a passive film, which would be directly related to the local breakdown, has not been well evaluated.

In this study, SECM was applied to a passive film formed on a pure iron and the heterogeneity of the passive film was examined from the difference in activity of redox reaction which takes place on the passive iron surface.

2. Experimental

2.1. SECM

A block diagram of the apparatus used for SECM experiments is shown in Fig. 1. A probe electrode is located just above a specimen electrode and it can detect the change in activity of a redox reaction on the specimen electrode as a probe current. If the distance (z axis) between the probe and specimen electrodes is kept constant and the probe electrode is scanned in the directions of x and y axes, the probe current images are obtained, from which the heterogeneity of the specimen surface would be evaluated.

Fig. 1. Block diagram of the apparatus used for SECM experiments.
A dual axes positioner with controller (Seiko Instr., SP-2200 and SP-4200) and three micro-positioners with controller (Chuo Precision Indust., AME-15 and M9103) were used for scanning (x and y axes) and positioning (z, $\theta_x$, and $\theta_y$ axes) the probe electrode, respectively. The probe electrode can be controlled with accuracies of 0.01 $\mu$m step$^{-1}$ in the x or y direction, of 0.1 $\mu$m step$^{-1}$ in the z direction, and of about $2 \times 10^{-9}$ degree step$^{-1}$ in the tilting (both $\theta_x$ and $\theta_y$). The potential, $E_p$, of probe electrode and the potential, $E_s$, of specimen electrode were controlled independently with a bipotentiostat (Hokuto Denko Co.) specially built for SECM. A silver–silver chloride electrode and a platinum plate were used as a reference electrode and a counter electrode, respectively, and all potentials were converted to a standard hydrogen electrode (SHE). The current, $I_p$, of probe electrode and the current, $I_s$, of specimen electrode were simultaneously measured as a function of the position of the probe electrode. Five dimensional ($x$, $y$, $z$, $\theta_x$, and $\theta_y$) and four electrochemical ($E_p$, $E_s$, $I_p$, and $I_s$) parameters were controlled and recorded with a personal computer.

### 2.2. Specimen Preparation and Experimental Set up

The probe electrode was a disc-shaped microelectrode composed of a platinum wire with a diameter of 10 $\mu$m which was thermally sealed into a glass capillary. The tip of the probe electrode was mechanically polished with a diamond whetstone ($\approx 5000$) on a turntable (Narishige Co., EG–400). For cleaning, cyclic voltammetry of the probe electrode was performed in the potential region between hydrogen evolution and oxygen evolution in 1 mol dm$^{-3}$ sulfuric acid until the same voltammograms as those used for scanning (x and y axes) and positioning (z, $\theta_x$, and $\theta_y$ axes) the probe electrode, respectively. The flat band potential, $E_{fb}$, of specimen electrode was employed as a mediator of the redox reaction taking place on the passivated iron. After the passivation, deaerated pH 8.4 borate solution containing 0.03 mol dm$^{-3}$ K$_4$Fe(CN)$_6$ was introduced into the SECM cell and then the potentials of probe and iron electrodes were controlled at $E_p = 1.2$ V and $E_s = 0.1$ V, respectively with the bipotentiostat. In this potential condition, the oxidation of Fe(CN)$_6^{3-}$ on the probe electrode at $E_p = 1.2$ V, whereas the reduction of Fe(CN)$_6^{4-}$ produced on the probe electrode proceeds on the iron electrode at $E_s = 0.1$ V. It is known that the flat band potential, $E_{fb}$, of the passive film on iron is $-0.16$ V in pH 8.4 borate solution. The passive film on iron in the solution may be cathodically reduced at potentials lower than $E_{fb}$, respectively. Therefore, $E_p = 0.1$ V higher than $E_{fb}$ was chosen to avoid the changes in thickness of the passive film during the measurement of probe current image.

If the distance between probe and specimen electrodes is short enough within the length of diffusion layer of Fe(CN)$_6^{3-}$ or Fe(CN)$_6^{4-}$ on the probe electrode in bulk solution, the oxidation of Fe(CN)$_6^{4-}$ on the probe electrode is enhanced or retarded just above the local sites of iron surface with a high or low reactivity of reduction of Fe(CN)$_6^{3-}$ due to a spatial limitation of diffusion as described later. The above mode in which probe current image is measured, is called “tip-generation/substrate-collection (TG/SC) mode" according to Bard et al.\textsuperscript{23,24} In this experiment, the distance between probe and specimen electrodes, $d_{sp}$, is so controlled as to the value of probe current being about 0.6 times as much as that of the limiting current measured when the probe electrode is located more than 200 $\mu$m far from the specimen electrode. According to our previous SECM study\textsuperscript{25} in which a model specimen electrode with platinum foil and wire embedded into epoxy resin was used, the lateral resolution of the probe current image measured at the above electrochemical and geometrical conditions was about twice as much as the diameter of probe electrode as shown in Fig. 3.

![Fig. 2. Specimen electrode with two iron plates embedded into epoxy resin.](image-url)
2.3. Observation of the Specimen Surface

A surface roughness of the iron specimen subjected to chemical etching was measured by a surface profilometer (Tokyo Seimitsu Co., Surfcom) equipped with a diamond tip (a diameter of 0.01 µm) for surface tracing. After the measurement of a probe current image, an optical micrograph of the same region was taken for comparison with the probe current image. Furthermore, the orientation of each crystal grain on the substrate iron surface was examined by an etch-pit method. Three different kinds of solutions (a), (b), and (c) as described in Table 1 were prepared for an etch-pit method. The iron specimen was immersed into these solutions in the following order: solution (a) for 10 s → solution (b) for 30 s → solution (c) for 10 s → solution (b) for 30 s. After every immersion, the iron specimen was rinsed with doubly distilled water. This etching treatment provides the shape of the pit depending on the orientation of each grain. Each pit is mainly composed of low index planes (\{100\} and \{110\}) of a polyhedron.\(^{26,27}\) The shape of each pit was confirmed with SEM observations, from which the orientation of the grain was evaluated.

### Table 1. Solutions (a), (b), and (c) prepared for an etch-pit method.

<table>
<thead>
<tr>
<th>Chemicals</th>
<th>Thier mixing ratios in volume</th>
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<tr>
<td>(a) HCl : H₂O₂ : H₂O</td>
<td>(1:10:100)</td>
</tr>
<tr>
<td>(b) sat. FeCl₃ aq. sol. : HNO₃ : H₂O</td>
<td>(2:1:10)</td>
</tr>
<tr>
<td>(c) HCOOH : H₂O₂ : C₂H₄OH : H₂O</td>
<td>(1:1:1:1)</td>
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3. Results and Discussion

3.1. Characteristics of Probe Electrode

Figure 4 shows the cyclic voltammogram of the probe electrode measured in deaerated pH 8.4 borate solution containing 0.03 mol dm\(^{-3}\) Fe(CN)₅\(^{2-}\) when the probe electrode is far from the specimen electrode. The cyclic voltammogram has a sigmoid shape with a limiting current, \(I_p \approx 41 \) nA at potentials above 0.6 V. This limiting current is in a good agreement with that derived theoretically for a disc microelectrode with a hemispherical diffusion layer. The theoretical limiting current, \(I_p, t\), can be described as follows.\(^{28}\)

\[
I_{p,t} = 4nFDCa \quad \text{...................................(1)}
\]

where \(D\) and \(C\) are the diffusion coefficient and the concentration of mediator, respectively, \(a\) is the diameter of probe electrode, \(n\) is the number of electrons participating in the redox reaction, and \(F\) is the Faraday constant. When the probe electrode approaches to the specimen electrode within a distance corresponding to the length of diffusion layer, the probe current, \(I_p\), changes depending on electronic properties of the specimen electrode surface due to a spatial limitation of diffusion.\(^{29,30}\) In case where the specimen electrode surface is insulative, the probe current, \(I_p\), decreases with decreasing the distance, \(d_{ep}\), because the reduction of Fe(CN)₅\(^{2-}\) occurs scarcely on the insulative surface and the supply of Fe(CN)₅\(^{2-}\) from the outside is spatially limited, that is, the probe electrode is subjected to a negative feedback condition. On the other hand, in case where the specimen electrode surface is a good electronic conductor, the probe current, \(I_p\), increases with decreasing the distance, \(d_{ep}\), because the reduction of Fe(CN)₅\(^{2-}\) proceeds easily on the electroconductive surface and the transport of Fe(CN)₅\(^{2-}\) to the outside is spatially limited, that is, the probe electrode is subjected...
3.2. Normalized Probe Current as a Function of the Distance between Probe and Iron Electrodes

After the iron electrode was passivated at $E_a = 0.4, 0.6, 0.8$ or $1.0$ V for $1$ h in deaerated pH 8.4 borate solution, the probe current, $I_p$, was measured at $E_a = 1.2$ V and $E_s = 0.1$ V in deaerated pH 8.4 borate solution containing 0.03 mol dm$^{-3}$ K$_4$Fe(CN)$_6$ as a function of the distance between probe and iron electrodes, $d_{s,p}$. In Fig. 5, the probe current normalized with a limiting probe current, $I_p/I_{p,l}$, was plotted vs. $d_{s,p}$. The value of $I_p/I_{p,l}$ decreases with increasing $d_{s,p}$, indicating that the passive iron surface is semiconductive or insulative. Moreover, at $d_{s,p}$ less than 15 µm, the value of $I_p/I_{p,l}$ decreases with increasing $E_a$.

It is known that the passive film on iron has a semiconductive property$^{31,32}$ of n type with a band gap energy of 1.6–2.0 eV. The ellipsometrical results$^3$ indicated that the thickness of passive films formed on iron in pH 8.4 borate solution increased linearly from 1 to 5 nm with increasing the potential of film formation, $E_a$. A transfer reaction of electrons between passive metal substrate and redox system in solution proceeds with a direct tunneling of electrons across the passive film, if the Fermi level of redox system is located in the forbidden band of the film and the film thickness is small enough (less than 3 nm) for tunneling. In this case, it is theoretically derived that the tunneling probability decreases exponentially with increasing the film thickness.

The decrease in $I_p/I_{p,l}$ with increasing $E_a$, i.e., the film thickness, at $d_{s,p}$ less than 15 µm in Fig. 5 reflects on the reactivity of the passive iron surface. In principle, therefore, the probe current image which is measured by scanning the probe electrode in the direction of x and y axes at $d_{s,p} = 5$ µm corresponding to $I_p/I_{p,l} = 0.6$ can evaluate the difference in thickness of passive films on iron. Schultze et al.$^{34}$ found that the redox current of Fe(CN)$_6^{3-}$ and Fe(CN)$_6^{4-}$ on iron electrode passivated in pH 8.4 borate solution decreased with increasing the film thickness. The results of Fig. 5 are consistent with those by Schultze et al.$^{34}$.

3.3. Evaluation of the Difference in Thickness of Passive Film from Probe Current Image

Figure 6(a) shows the probe current image of the specimen electrode with two iron plates separated with epoxy resin. The two iron plates were anodically polarized at $E_a = 0.6$ and 1.0 V (SHE) for 1 h to form the passive films$^{33}$ with different thickness (3.8 and 4.9 nm), respectively, prior to the measurement of the probe current image. For the measurement of the probe current image, the probe and iron electrodes were polarized at 1.2 and 0.1 V (SHE), respectively, in deaerated pH 8.4 borate solution containing 0.03 mol dm$^{-3}$ K$_4$Fe(CN)$_6$.

(b) Probe current profile along the dashed line drawn in Fig. 6(a).
estimated to be 23 \mu m from the probe current profile at the boundary between epoxy resin and iron plate with passive film formed at 1.0 V, which was slightly larger than two times as much as a diameter of the probe electrode.

3.4. Heterogeneity of the Passive Film Associated with Orientation of the Substrate Crystal Grain

Figure 7(a) shows the probe current image measured after the iron electrode surface with distinctive crystal grains was passivated at 1.0 V (SHE) for 1 h. For the measurement of the probe current image, the probe and iron electrodes were polarized at 1.2 and 0.1 V (SHE), respectively, in deaerated pH 8.4 borate solution containing 0.03 mol dm\(^{-3}\) K\(_4\)Fe(CN)\(_6\). (b) Probe current profile along the dashed line drawn in Fig. 7(a).

Fig. 8. Optical micrograph of the same surface region where the probe current image was measured. The index planes described on the optical micrograph represent the orientation of each crystal grain evaluated from the shape of the etch pit. The real deviation from the index plane is described by rotation angles about \([100]\) and \([010]\) axes in the table.

<table>
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<tr>
<th>Index plane</th>
<th>rotation angle</th>
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<tr>
<td>a</td>
<td>(011) - 10° 5°</td>
</tr>
<tr>
<td>b</td>
<td>(111) 0° - 5°</td>
</tr>
<tr>
<td>c</td>
<td>(101) - 5°</td>
</tr>
<tr>
<td>d</td>
<td>(001) 10°</td>
</tr>
<tr>
<td>e</td>
<td>(001) 10°</td>
</tr>
<tr>
<td>f</td>
<td>(101) - 10° 5°</td>
</tr>
<tr>
<td>g</td>
<td>(101) 0°</td>
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</table>

Kudelka et al.\(^{35}\) measured the thickness of passive films formed on a polycrystalline titanium electrode by an anisotropy micro-ellipsometry\(^{36}\) and found that the passive film formed on the (0001) grain with the high
packing density of the substrate surface is thinner than that on the (xxx0) grain with the low packing density. In case of iron, the packing density of the {110} grain surface is higher than that of the {100} grain surface. The similar relation between the thickness of the passive film and the packing density of the substrate grain may hold for iron as well as titanium. The reason why the thinner passive film is formed on the substrate grain with the higher packing density is not well understood, although it is probable that the high packing density hinders the penetration of the electric field into the metal surface and suppresses the passive film growth.\(^{35}\) We need further experiments to confirm the dependence of passive film thickness on the orientation of the substrate iron grains.

4. Conclusions

SECM was applied to evaluate the heterogeneity of passive film formed on a polycrystalline iron electrode in deaerated pH 8.4 borate solution. The following conclusions were drawn.

(1) The difference in thickness of passive films formed on two iron plates at different potentials could be evaluated from the probe current image measured in deaerated pH 8.4 borate solution containing Fe(CN)\(_6^{4-}\) as a mediator.

(2) The shapes of the patch patterns on the probe current image coincided completely with the shapes of crystal grains on the substrate iron surface.

(3) The probe current flowed above the grain surface oriented to {100} plane was less than that above the grain surface oriented to {110} or {111} plane.

(4) The grain orientation dependence of probe current was ascribed to the difference in thickness of passive films formed on the crystal grains.

Acknowledgments

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